Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/798,277	MAEDE ET AL.
Examiner	Art Unit
Trinh Vo Dinh	2821

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search (US,UPGPUB,EPO,IBM,JPO,DERWE NT) 315/169.1, 169.3, 169.4 345/76,77, 84, 204, 214 (See search history printout)	7/20/2005	T.D		
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